Se	arch	Note	S

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/651,039	IWATA ET AL.	
Examiner	Art Unit	
Tawfik Goma	2627	

SEARCHED			
Subclass	Date	Examiner	
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	Subclass	Subclass Date	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
		,	
East (US see attached sea		1/4/2007	TG

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
East (US-PGPUB, USPAT, EPO, JPO, Derwent, IBM_TDB) search updated, see attached	1/4/2007	ТG